

N-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR SWITCHING

DESCRIPTION

The μ PA1807 is a switching device, which can be driven directly by a 4.0 V power source.

This device features a low on-state resistance and excellent switching characteristics, and is suitable for applications such as DC/DC converters and power management of notebook computers and so on.

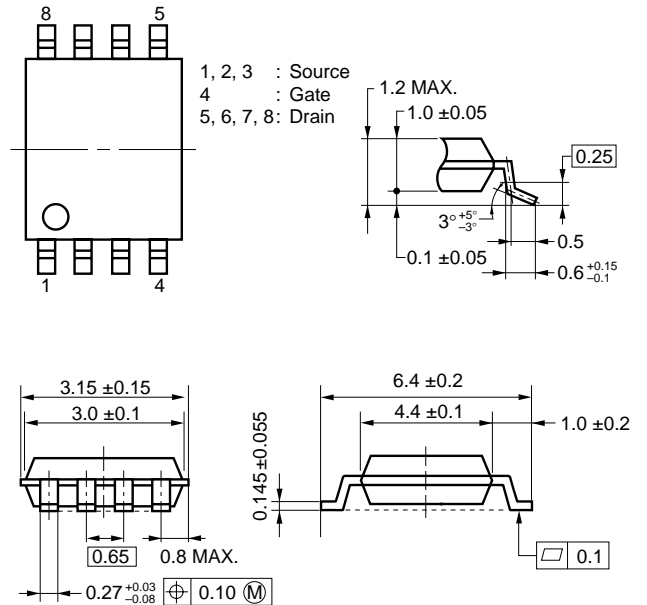
FEATURES

- 4.0 V drive available
- Low on-state resistance
 - $R_{DS(on)1} = 10 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 6.0 \text{ A)}$
 - $R_{DS(on)2} = 14 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.5 \text{ V, } I_D = 6.0 \text{ A)}$
 - $R_{DS(on)3} = 16 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.0 \text{ V, } I_D = 6.0 \text{ A)}$
- Built-in G-S protection diode against ESD

ORDERING INFORMATION

| PART NUMBER | PACKAGE |
|--------------------|--------------|
| μ PA1807GR-9JG | Power TSSOP8 |

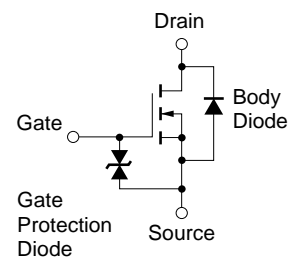
PACKAGE DRAWING (Unit: mm)



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$)

| | | | |
|--|----------------|-------------|------------------|
| Drain to Source Voltage ($V_{GS} = 0 \text{ V}$) | V_{DSS} | 30 | V |
| Gate to Source Voltage ($V_{DS} = 0 \text{ V}$) | V_{GSS} | ± 20 | V |
| Drain Current (DC) ($T_A = 25^\circ\text{C}$) | $I_{D(DC)}$ | ± 12 | A |
| Drain Current (pulse) ^{Note1} | $I_{D(pulse)}$ | ± 48 | A |
| Total Power Dissipation ^{Note2} | P_T | 2.0 | W |
| Channel Temperature | T_{ch} | 150 | $^\circ\text{C}$ |
| Storage Temperature | T_{stg} | -55 to +150 | $^\circ\text{C}$ |

EQUIVALENT CIRCUIT



- Notes**
1. $PW \leq 10 \mu\text{s}$, Duty Cycle $\leq 1\%$
 2. Mounted on ceramic substrate of $5000 \text{ mm}^2 \times 1.1 \text{ mm}$

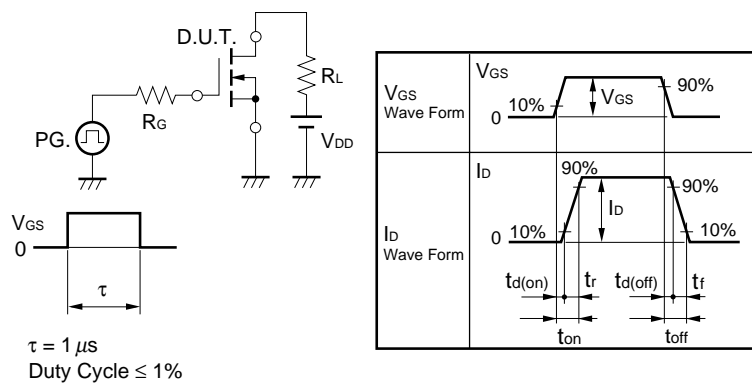
Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

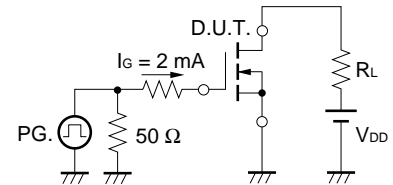
ELECTRICAL CHARACTERISTICS (T_A = 25°C)

| CHARACTERISTICS | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-------------------------------------|----------------------|---|------|------|------|------|
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 30 V, V _{GS} = 0 V | | | 1.0 | μA |
| Gate Leakage Current | I _{GSS} | V _{GS} = ±20 V, V _{DS} = 0 V | | | ±10 | μA |
| Gate Cut-off Voltage | V _{GS(off)} | V _{DS} = 10 V, I _D = 1.0 mA | 1.5 | 2.0 | 2.5 | V |
| Forward Transfer Admittance | y _{ts} | V _{DS} = 10 V, I _D = 6.0 A | 7.0 | 15 | | S |
| Drain to Source On-state Resistance | R _{DS(on)1} | V _{GS} = 10 V, I _D = 6.0 A | | 8.1 | 10 | mΩ |
| | R _{DS(on)2} | V _{GS} = 4.5 V, I _D = 6.0 A | | 10.5 | 14 | mΩ |
| | R _{DS(on)3} | V _{GS} = 4.0 V, I _D = 6.0 A | | 12 | 16 | mΩ |
| Input Capacitance | C _{iSS} | V _{DS} = 10 V | | 1000 | | pF |
| Output Capacitance | C _{oss} | V _{GS} = 0 V | | 390 | | pF |
| Reverse Transfer Capacitance | C _{rss} | f = 1.0 MHz | | 140 | | pF |
| Turn-on Delay Time | t _{d(on)} | V _{DD} = 15 V, I _D = 6.0 A | | 16 | | ns |
| Rise Time | t _r | V _{GS} = 10 V | | 11 | | ns |
| Turn-off Delay Time | t _{d(off)} | R _G = 10 Ω | | 46 | | ns |
| Fall Time | t _f | | | 11.5 | | ns |
| Total Gate Charge | Q _G | V _{DD} = 24 V | | 19 | | nC |
| Gate to Source Charge | Q _{GS} | V _{GS} = 10 V | | 3.1 | | nC |
| Gate to Drain Charge | Q _{GD} | I _D = 12 A | | 5.0 | | nC |
| Body Diode Forward Voltage | V _{F(S-D)} | I _F = 12 A, V _{GS} = 0 V | | 0.82 | | V |
| Reverse Recovery Time | t _{rr} | I _F = 12 A, V _{GS} = 0 V | | 32 | | ns |
| Reverse Recovery Charge | Q _{rr} | di/dt = 100 A/μs | | 24 | | nC |

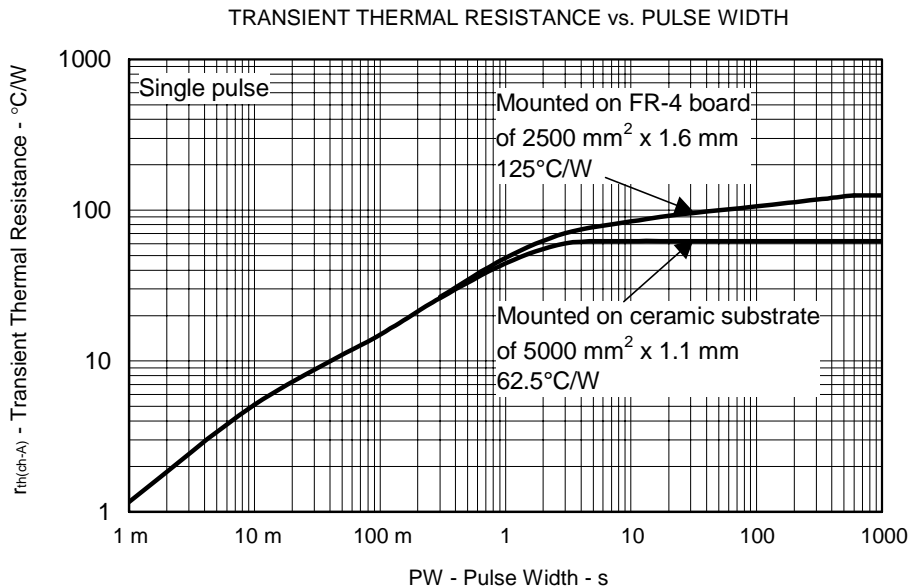
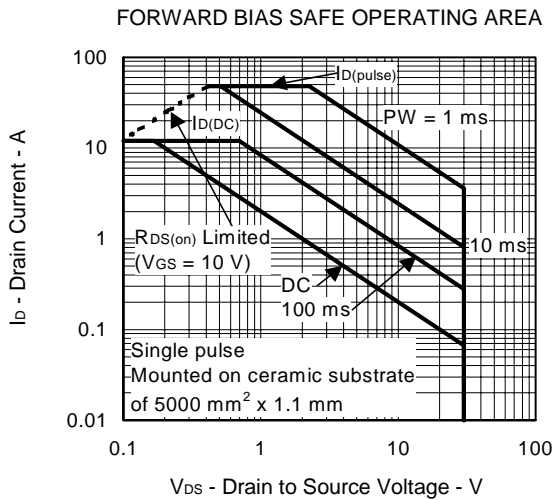
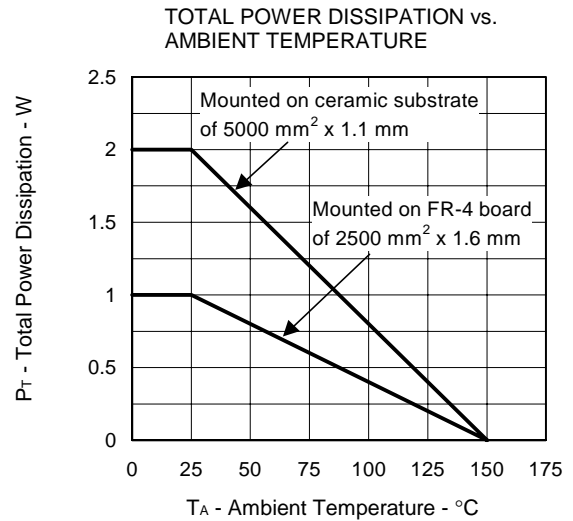
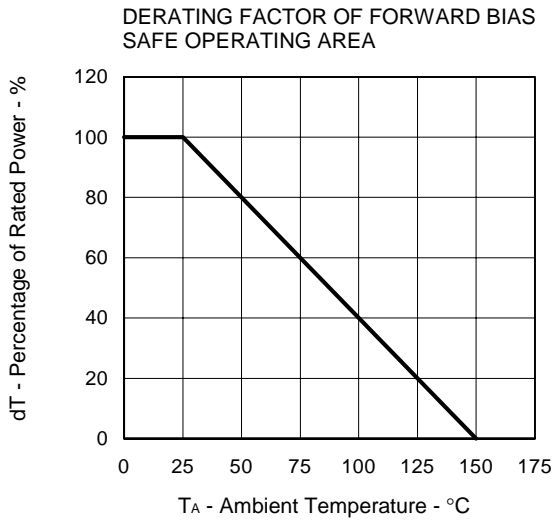
TEST CIRCUIT 1 SWITCHING TIME



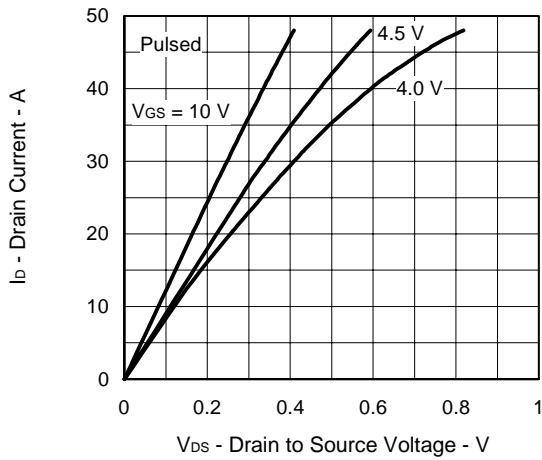
TEST CIRCUIT 2 GATE CHARGE



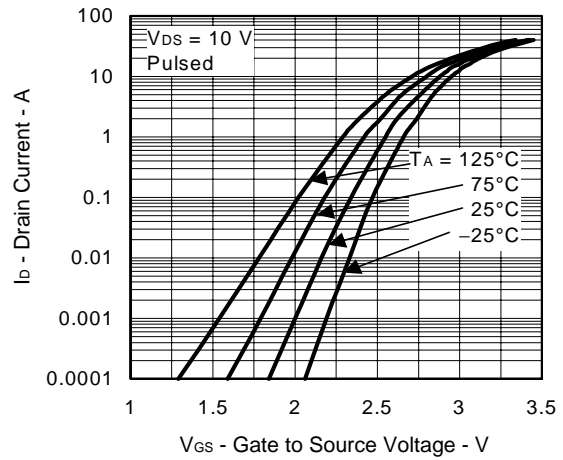
TYPICAL CHARACTERISTICS (T_A = 25°C)



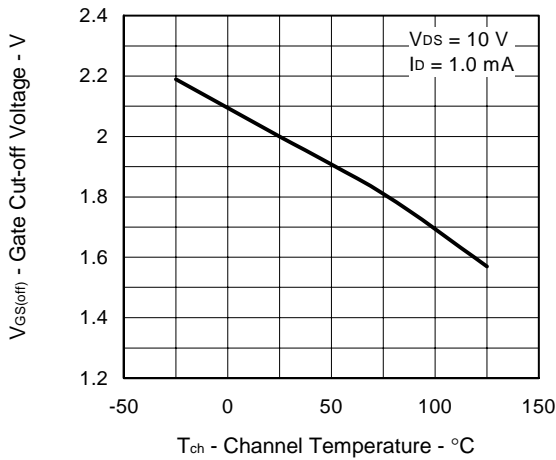
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



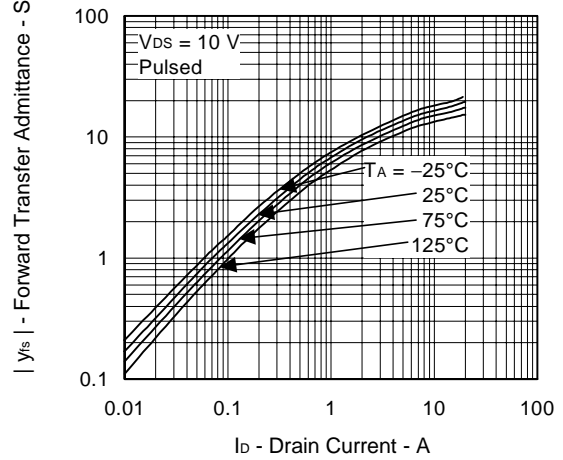
FORWARD TRANSFER CHARACTERISTICS



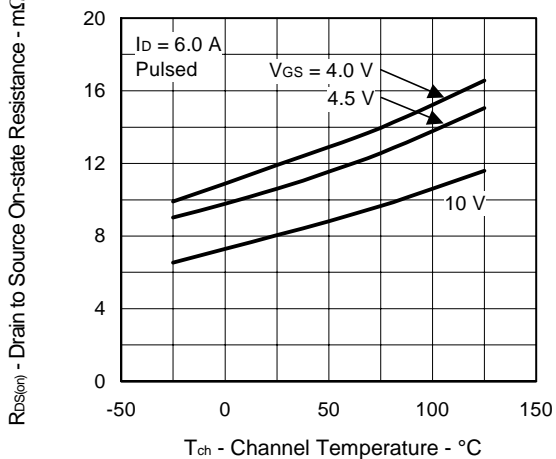
GATE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



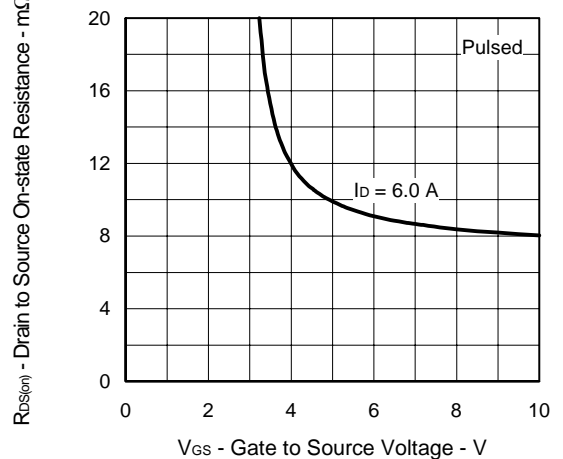
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



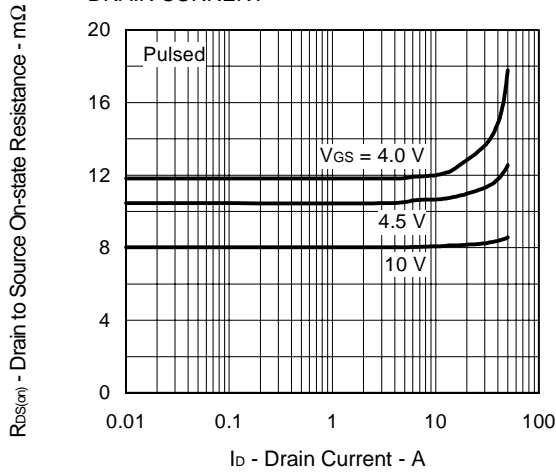
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



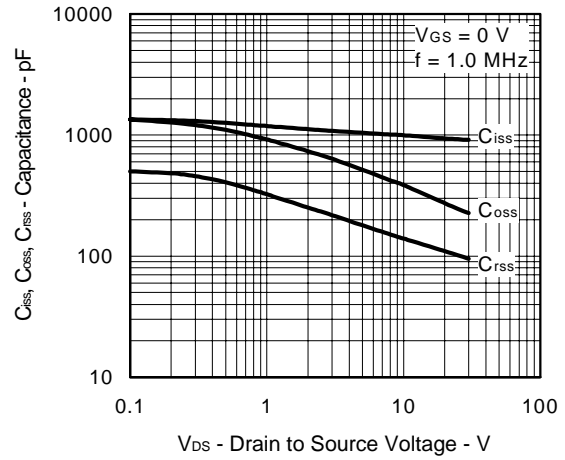
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



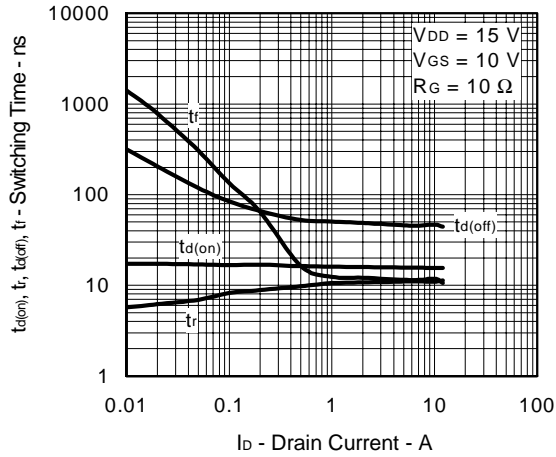
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



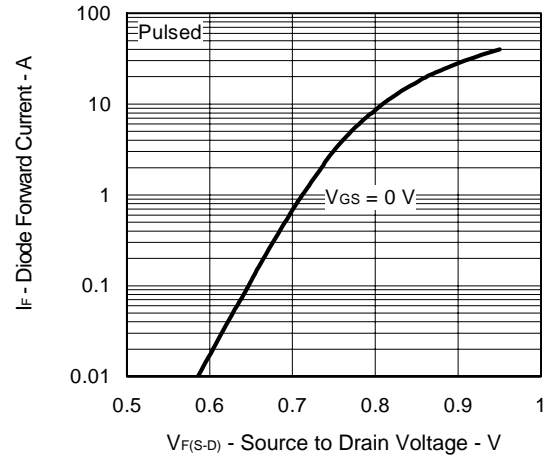
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



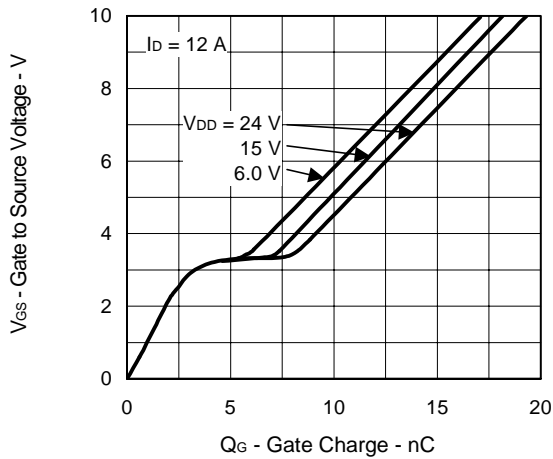
SWITCHING CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



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